

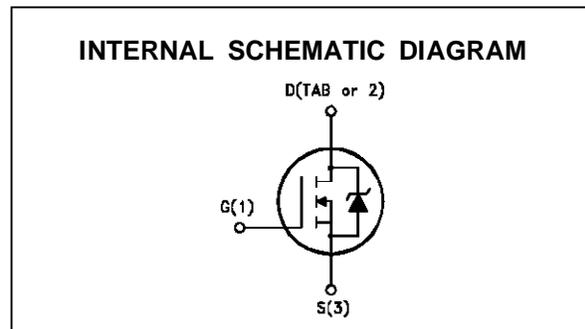
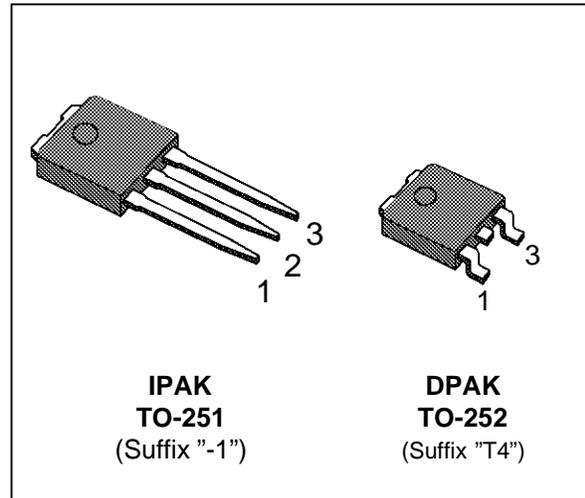
## N - CHANNEL ENHANCEMENT MODE POWER MOS TRANSISTOR

| TYPE     | V <sub>DSS</sub> | R <sub>DS(on)</sub> | I <sub>D</sub> |
|----------|------------------|---------------------|----------------|
| STD10N10 | 100 V            | < 0.2 Ω             | 10 A           |

- TYPICAL R<sub>DS(on)</sub> = 0.135 Ω
- AVALANCHE RUGGED TECHNOLOGY
- 100% AVALANCHE TESTED
- REPETITIVE AVALANCHE DATA AT 100°C
- LOW GATE CHARGE
- HIGH CURRENT CAPABILITY
- 175°C OPERATING TEMPERATURE
- APPLICATION ORIENTED CHARACTERIZATION
- THROUGH-HOLE IPAK (TO-251) POWER PACKAGE IN TUBE (SUFFIX "-1")
- SURFACE-MOUNTING DPAK (TO-252) POWER PACKAGE IN TAPE & REEL (SUFFIX "T4")

### APPLICATIONS

- HIGH CURRENT, HIGH SPEED SWITCHING
- SOLENOID AND RELAY DRIVERS
- REGULATORS
- DC-DC & DC-AC CONVERTERS
- MOTOR CONTROL, AUDIO AMPLIFIERS
- AUTOMOTIVE ENVIRONMENT (INJECTION, ABS, AIR-BAG, LAMPDRIVERS, Etc.)



### ABSOLUTE MAXIMUM RATINGS

| Symbol              | Parameter   | Value      | Unit |
|---------------------|---|------------|------|
| V <sub>DS</sub>     | Drain-source Voltage (V <sub>GS</sub> = 0)            | 100        | V    |
| V <sub>DGR</sub>    | Drain- gate Voltage (R <sub>GS</sub> = 20 kΩ)         | 100        | V    |
| V <sub>GS</sub>     | Gate-source Voltage                                   | ± 20       | V    |
| I <sub>D</sub>      | Drain Current (continuous) at T <sub>c</sub> = 25 °C  | 10         | A    |
| I <sub>D</sub>      | Drain Current (continuous) at T <sub>c</sub> = 100 °C | 7          | A    |
| I <sub>DM</sub> (●) | Drain Current (pulsed)                                | 40         | A    |
| P <sub>tot</sub>    | Total Dissipation at T <sub>c</sub> = 25 °C           | 50         | W    |
|                     | Derating Factor                                       | 0.33       | W/°C |
| T <sub>stg</sub>    | Storage Temperature                                   | -65 to 175 | °C   |
| T <sub>j</sub>      | Max. Operating Junction Temperature                   | 175        | °C   |

(●) Pulse width limited by safe operating area

## STD10N10

### THERMAL DATA

|                |  |     |     |               |
|----------------|--|-----|-----|---------------|
| $R_{thj-case}$ | Thermal Resistance Junction-case               | Max | 3   | $^{\circ}C/W$ |
| $R_{thj-amb}$  | Thermal Resistance Junction-ambient            | Max | 100 | $^{\circ}C/W$ |
| $R_{thc-sink}$ | Thermal Resistance Case-sink                   | Typ | 1.5 | $^{\circ}C/W$ |
| $T_l$          | Maximum Lead Temperature For Soldering Purpose |     | 275 | $^{\circ}C$   |

### AVALANCHE CHARACTERISTICS

| Symbol   | Parameter   | Max Value | Unit |
|----------|---|-----------|------|
| $I_{AR}$ | Avalanche Current, Repetitive or Not-Repetitive (pulse width limited by $T_j$ max, $\delta < 1\%$ )                         | 10        | A    |
| $E_{AS}$ | Single Pulse Avalanche Energy (starting $T_j = 25^{\circ}C$ , $I_D = I_{AR}$ , $V_{DD} = 25 V$ )                            | 40        | mJ   |
| $E_{AR}$ | Repetitive Avalanche Energy (pulse width limited by $T_j$ max, $\delta < 1\%$ )   | 10        | mJ   |
| $I_{AR}$ | Avalanche Current, Repetitive or Not-Repetitive ( $T_c = 100^{\circ}C$ , pulse width limited by $T_j$ max, $\delta < 1\%$ ) | 7         | A    |

### ELECTRICAL CHARACTERISTICS ( $T_{case} = 25^{\circ}C$ unless otherwise specified)

OFF

| Symbol        | Parameter  | Test Conditions  | Min. | Typ. | Max.        | Unit               |
|---------------|--|--|------|------|-------------|--------------------|
| $V_{(BR)DSS}$ | Drain-source Breakdown Voltage                   | $I_D = 250 \mu A$ $V_{GS} = 0$   | 100  |      |             | V                  |
| $I_{DSS}$     | Zero Gate Voltage Drain Current ( $V_{GS} = 0$ ) | $V_{DS} = \text{Max Rating}$<br>$V_{DS} = \text{Max Rating} \times 0.8$ $T_c = 125^{\circ}C$ |      |      | 250<br>1000 | $\mu A$<br>$\mu A$ |
| $I_{GSS}$     | Gate-body Leakage Current ( $V_{DS} = 0$ )       | $V_{GS} = \pm 20 V$  |      |      | $\pm 100$   | nA                 |

ON (\*)

| Symbol       | Parameter                         | Test Conditions   | Min. | Typ.  | Max.       | Unit                 |
|--------------|-----------------------------------|---|------|-------|------------|----------------------|
| $V_{GS(th)}$ | Gate Threshold Voltage            | $V_{DS} = V_{GS}$ $I_D = 250 \mu A$   | 2    | 3     | 4          | V                    |
| $R_{DS(on)}$ | Static Drain-source On Resistance | $V_{GS} = 10V$ $I_D = 5 A$<br>$V_{GS} = 10V$ $I_D = 5 A$ $T_c = 100^{\circ}C$ |      | 0.135 | 0.2<br>0.4 | $\Omega$<br>$\Omega$ |
| $I_{D(on)}$  | On State Drain Current            | $V_{DS} > I_{D(on)} \times R_{DS(on)max}$<br>$V_{GS} = 10 V$                  | 10   |       |            | A                    |

### DYNAMIC

| Symbol       | Parameter                    | Test Conditions                                       | Min. | Typ. | Max. | Unit |
|--------------|------------------------------|---|------|------|------|------|
| $g_{fs} (*)$ | Forward Transconductance     | $V_{DS} > I_{D(on)} \times R_{DS(on)max}$ $I_D = 5 A$ | 3    | 5    |      | S    |
| $C_{iss}$    | Input Capacitance            | $V_{DS} = 25 V$ $f = 1 MHz$ $V_{GS} = 0$              |      | 580  | 750  | pF   |
| $C_{oss}$    | Output Capacitance           |   |      | 140  | 200  | pF   |
| $C_{rss}$    | Reverse Transfer Capacitance |   |      | 40   | 60   | pF   |

**ELECTRICAL CHARACTERISTICS** (continued)

**SWITCHING ON**

| Symbol                        | Parameter  | Test Conditions  | Min. | Typ.         | Max.     | Unit             |
|-------------------------------|--|--|------|--------------|----------|------------------|
| $t_{d(on)}$<br>$t_r$          | Turn-on Time<br>Rise Time                                    | $V_{DD} = 50\text{ V}$ $I_D = 5\text{ A}$<br>$R_G = 4.7\ \Omega$ $V_{GS} = 10\text{ V}$<br>(see test circuit, figure 3)  |      | 10<br>40     | 15<br>60 | ns<br>ns         |
| $(di/dt)_{on}$                | Turn-on Current Slope  | $V_{DD} = 80\text{ V}$ $I_D = 10\text{ A}$<br>$R_G = 4.7\ \Omega$ $V_{GS} = 10\text{ V}$<br>(see test circuit, figure 5) |      | 600          |          | A/ $\mu\text{s}$ |
| $Q_g$<br>$Q_{gs}$<br>$Q_{gd}$ | Total Gate Charge<br>Gate-Source Charge<br>Gate-Drain Charge | $V_{DD} = 80\text{ V}$ $I_D = 10\text{ A}$ $V_{GS} = 10\text{ V}$  |      | 22<br>7<br>8 | 30       | nC<br>nC<br>nC   |

**SWITCHING OFF**

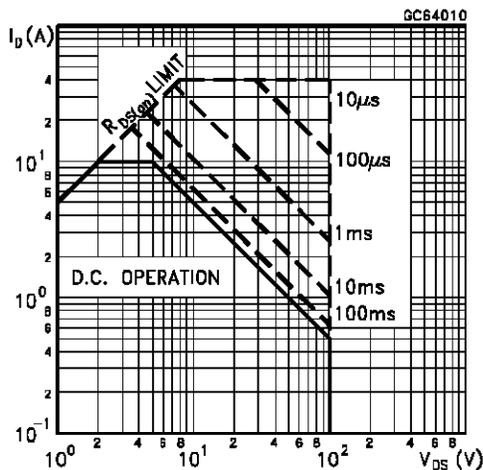
| Symbol                          | Parameter   | Test Conditions  | Min. | Typ.           | Max.           | Unit           |
|---------------------------------|---|--|------|----------------|----------------|----------------|
| $t_{r(Voff)}$<br>$t_f$<br>$t_c$ | Off-voltage Rise Time<br>Fall Time<br>Cross-over Time | $V_{DD} = 80\text{ V}$ $I_D = 10\text{ A}$<br>$R_G = 4.7\ \Omega$ $V_{GS} = 10\text{ V}$<br>(see test circuit, figure 5) |      | 10<br>10<br>20 | 15<br>15<br>30 | ns<br>ns<br>ns |

**SOURCE DRAIN DIODE**

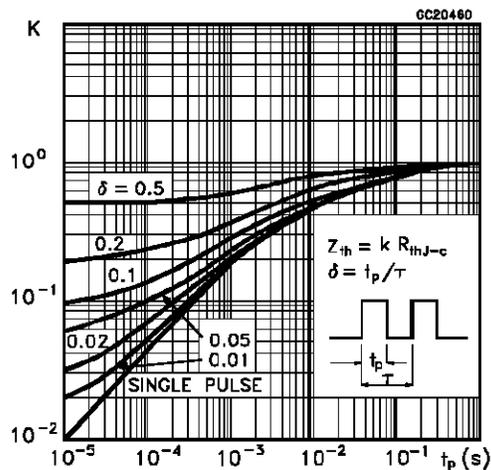
| Symbol                            | Parameter  | Test Conditions   | Min. | Typ.            | Max.     | Unit                     |
|-----------------------------------|--|---|------|-----------------|----------|--------------------------|
| $I_{SD}$<br>$I_{SDM}(\bullet)$    | Source-drain Current<br>Source-drain Current (pulsed)                        |   |      |                 | 10<br>40 | A<br>A                   |
| $V_{SD} (*)$                      | Forward On Voltage   | $I_{SD} = 10\text{ A}$ $V_{GS} = 0$   |      |                 | 1.5      | V                        |
| $t_{rr}$<br>$Q_{rr}$<br>$I_{RRM}$ | Reverse Recovery Time<br>Reverse Recovery Charge<br>Reverse Recovery Current | $I_{SD} = 10\text{ A}$ $di/dt = 100\text{ A}/\mu\text{s}$<br>$V_{DD} = 50\text{ V}$ $T_j = 150\text{ }^\circ\text{C}$<br>(see test circuit, figure 5) |      | 100<br>0.4<br>8 |          | ns<br>$\mu\text{C}$<br>A |

(\*) Pulsed: Pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5 %  
 (•) Pulse width limited by safe operating area

**Safe Operating Area**

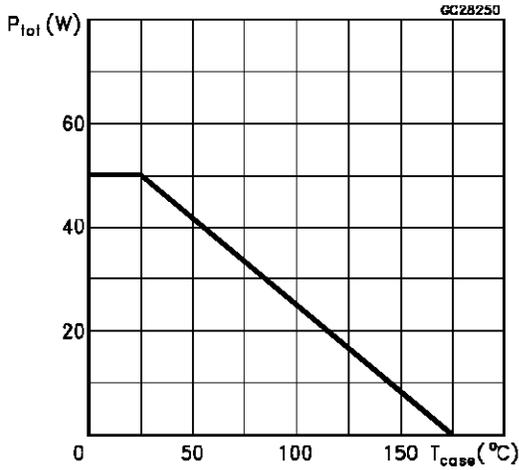


**Thermal Impedance**

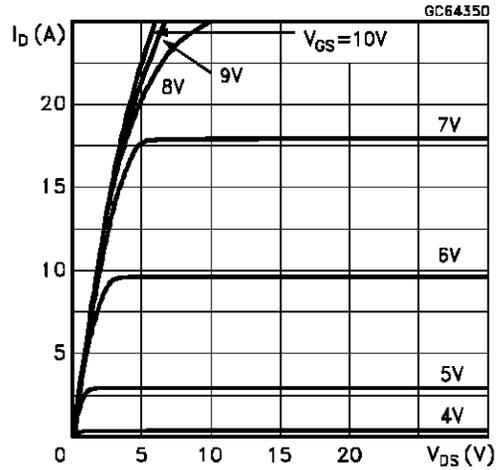


# STD10N10

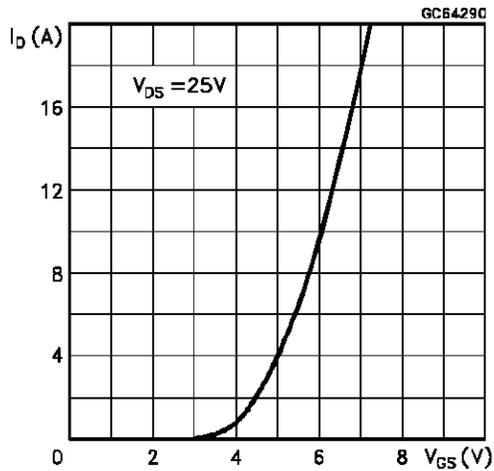
Derating Curve



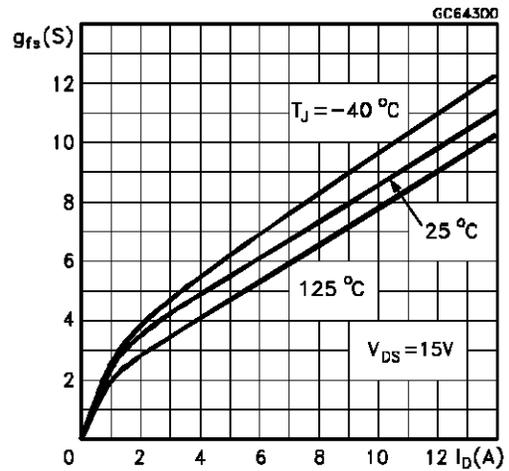
Output Characteristics



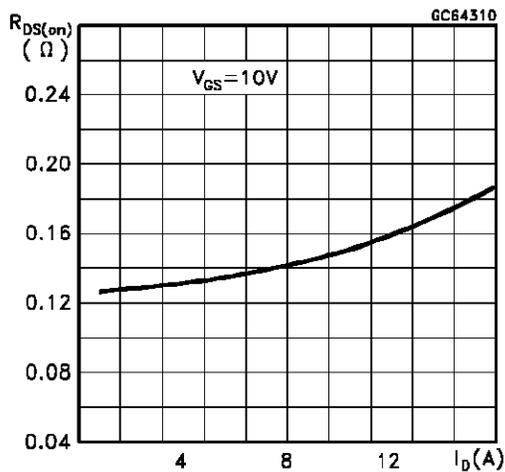
Transfer Characteristics



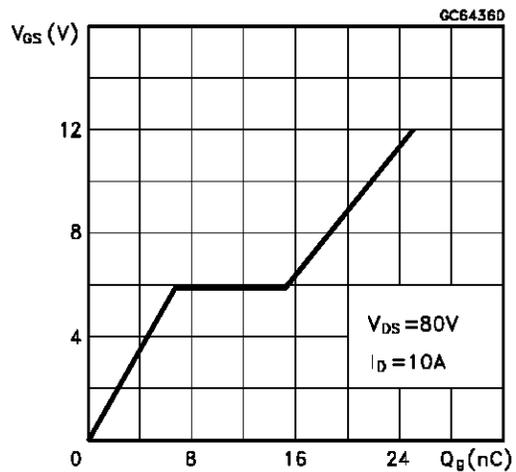
Transconductance



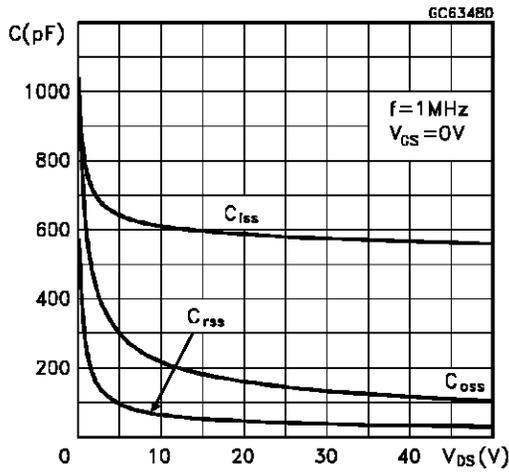
Static Drain-source On Resistance



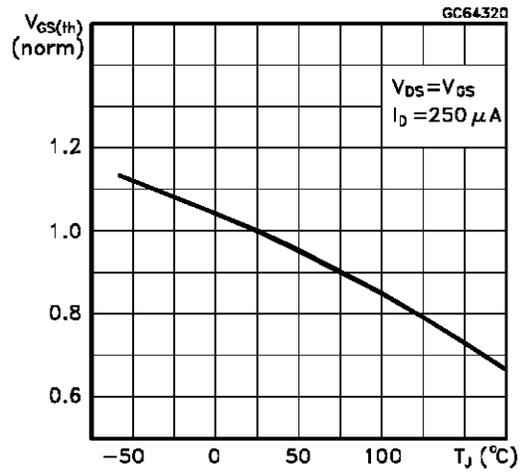
Gate Charge vs Gate-source Voltage



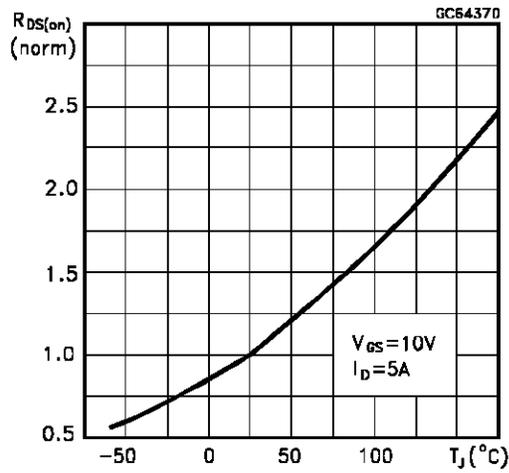
Capacitance Variations



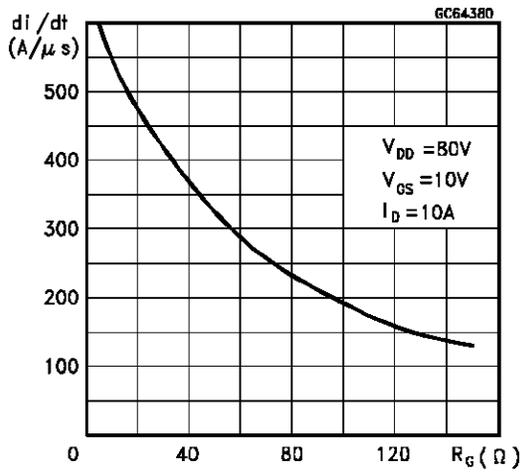
Normalized Gate Threshold Voltage vs Temperature



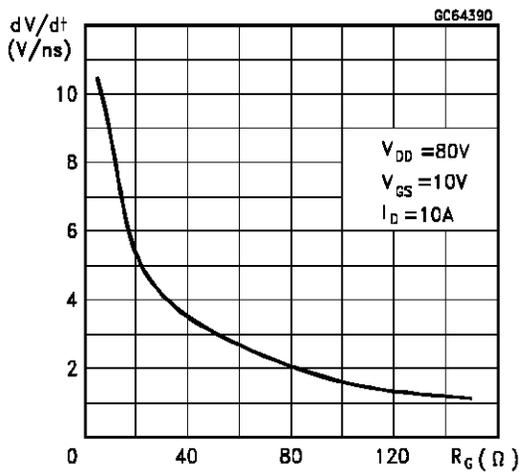
Normalized On Resistance vs Temperature



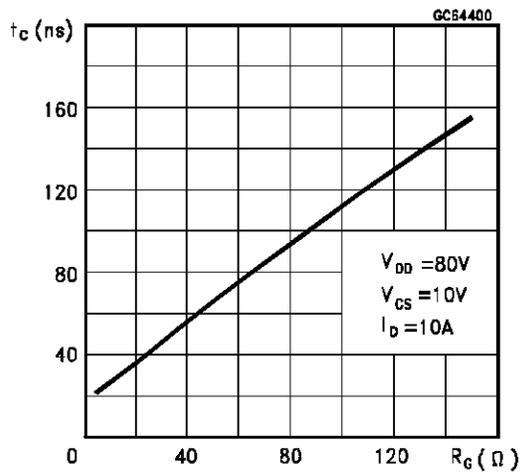
Turn-on Current Slope



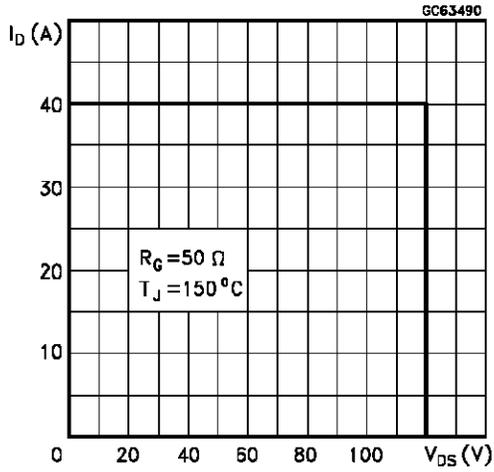
Turn-off Drain-source Voltage Slope



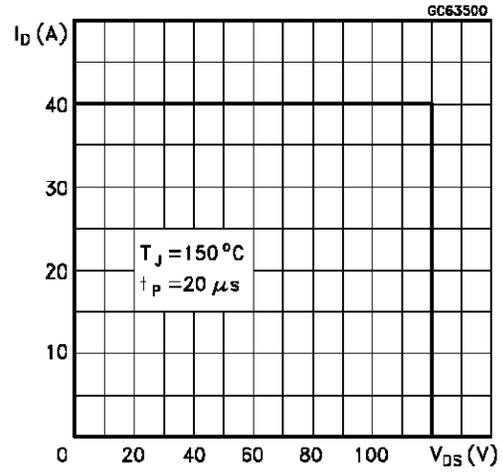
Cross-over Time



Switching Safe Operating Area



Accidental Overload Area



Source-drain Diode Forward Characteristics

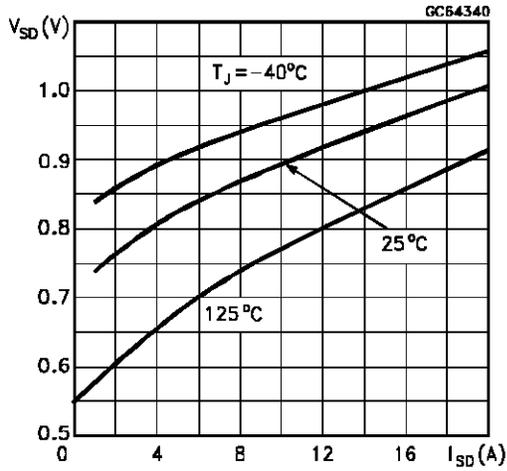
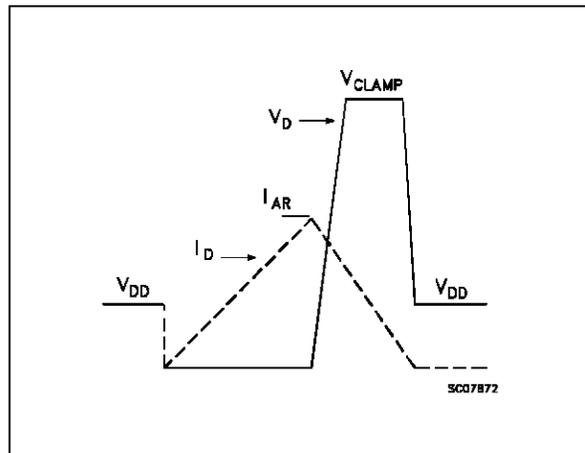
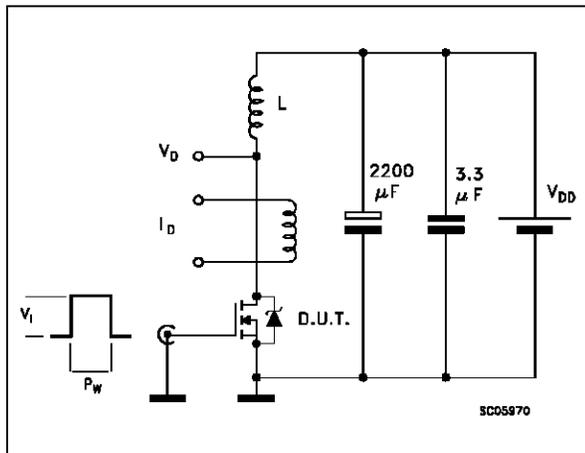
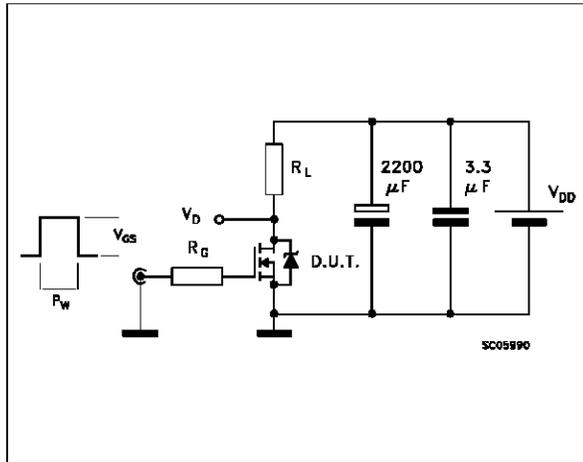


Fig. 1: Unclamped Inductive Load Test Circuits

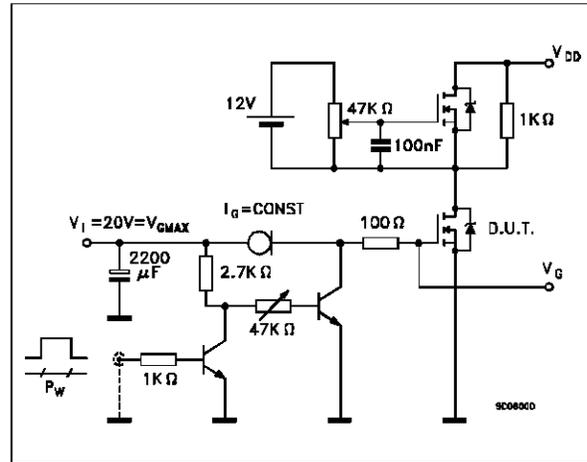
Fig. 2: Unclamped Inductive Waveforms



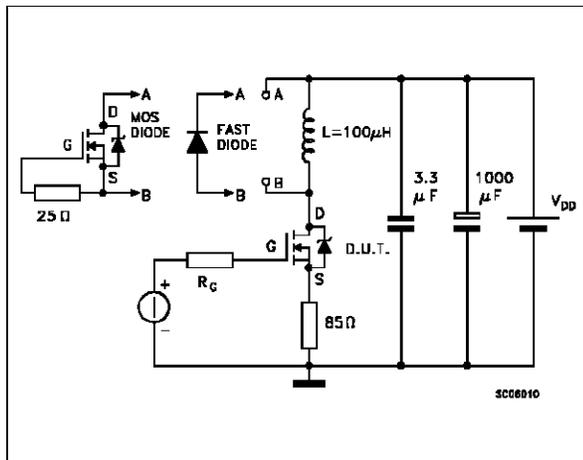
**Fig. 3:** Switching Times Test Circuits For Resistive Load



**Fig. 4:** Gate Charge Test Circuit



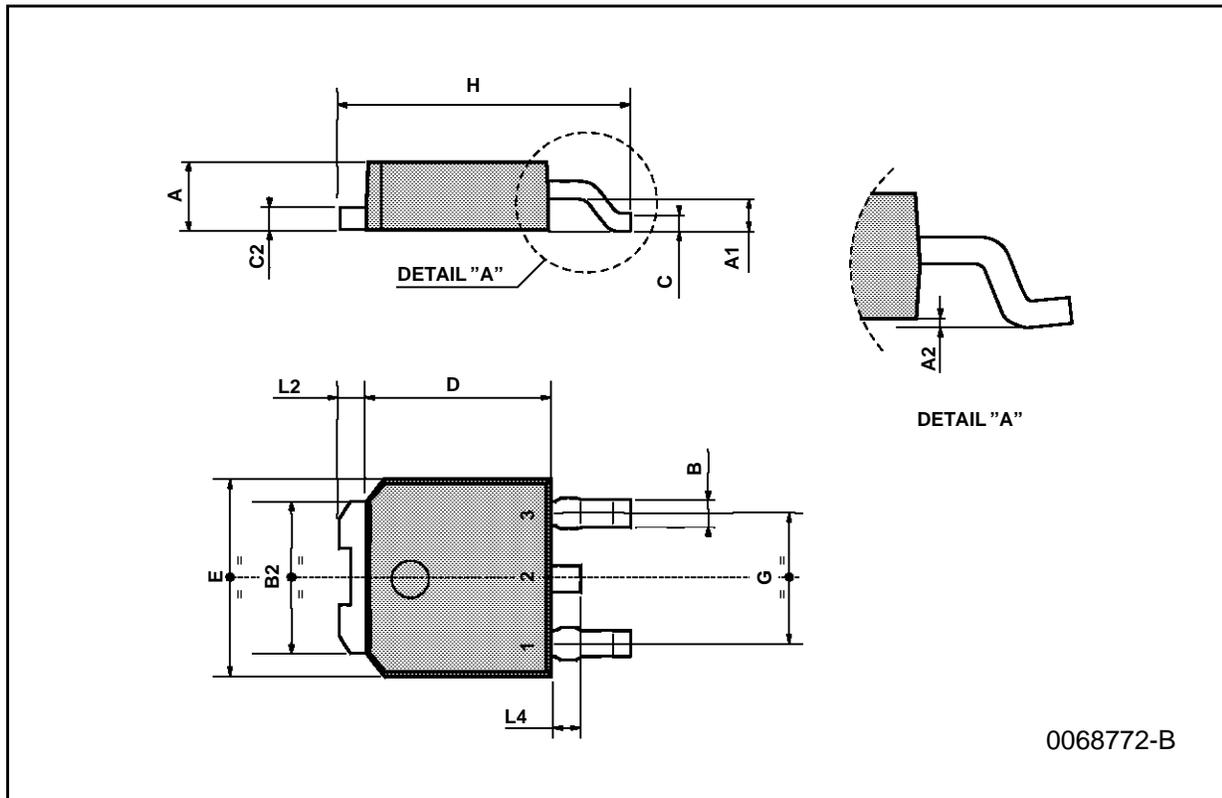
**Fig. 5:** Test Circuit For Inductive Load Switching And Diode Recovery Times





**TO-252 (DPAK) MECHANICAL DATA**

| DIM. | mm   |      |      | inch  |       |       |
|------|------|------|------|-------|-------|-------|
|      | MIN. | TYP. | MAX. | MIN.  | TYP.  | MAX.  |
| A    | 2.2  |      | 2.4  | 0.086 |       | 0.094 |
| A1   | 0.9  |      | 1.1  | 0.035 |       | 0.043 |
| A2   | 0.03 |      | 0.23 | 0.001 |       | 0.009 |
| B    | 0.64 |      | 0.9  | 0.025 |       | 0.035 |
| B2   | 5.2  |      | 5.4  | 0.204 |       | 0.212 |
| C    | 0.45 |      | 0.6  | 0.017 |       | 0.023 |
| C2   | 0.48 |      | 0.6  | 0.019 |       | 0.023 |
| D    | 6    |      | 6.2  | 0.236 |       | 0.244 |
| E    | 6.4  |      | 6.6  | 0.252 |       | 0.260 |
| G    | 4.4  |      | 4.6  | 0.173 |       | 0.181 |
| H    | 9.35 |      | 10.1 | 0.368 |       | 0.397 |
| L2   |      | 0.8  |      |       | 0.031 |       |
| L4   | 0.6  |      | 1    | 0.023 |       | 0.039 |



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